Small Signal MOSFET

25 V, 1.2 A, Single, N-Channel, SC-88

Features

- Advance Planar Technology for Fast Switching, Low R_{DS(on)}
- Higher Efficiency Extending Battery Life
- AEC-Q101 Qualified and PPAP Capable NVJS4405N
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Boost and Buck Converter
- Load Switch
- Battery Protection

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit | | |
|--|--------------------------------------|-----------------------|-----------------|------|---|
| Drain-to-Source Voltage | V_{DSS} | 25 | V | | |
| Gate-to-Source Voltage | V _{GS} | ±8.0 | V | | |
| Drain Current | t < 5 s | T _A = 25°C | I _D | 1.2 | Α |
| Continuous Drain Current | Steady | T _A = 25°C | I _D | 1.0 | Α |
| (Note 1) | State T _A = 75°C | | | 0.80 | |
| Power Dissipation (Note 1) | Stead | dy State | P_{D} | 0.63 | W |
| Power Dissipation (Note 1) | t≤ | ≤ 5 s | P _D | 0.89 | W |
| Pulsed Drain Current | t _p = | 10 μs | I _{DM} | 3.7 | Α |
| Operating Junction and Sto | T _J , T _{STG} | -55 to +150 | °C | | |
| Source Current (Body Dioc | I _S | 0.8 | Α | | |
| Lead Temperature for Sold (1/8" from case for 10 s | TL | 260 | °C | | |
| ESD Rating - Machine Mo | | 25 | V | | |

THERMAL RESISTANCE RATINGS

| Rating | Symbol | Max | Unit |
|---|-----------------|-----|------|
| Junction-to-Lead - Steady State (Note 1) | $R_{	heta JL}$ | 102 | °C/W |
| Junction-to-Ambient - Steady State (Note 1) | $R_{\theta JA}$ | 200 | |
| Junction-to-Ambient - t ≤ 5 s (Note 1) | $R_{\theta JA}$ | 140 | |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1

1. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

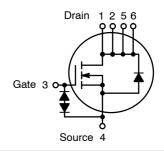


ON Semiconductor®

http://onsemi.com

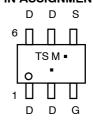
| V _{(BR)DSS} | V _{(BR)DSS} R _{DS(on)} Typ | |
|----------------------|--|-------|
| 25 V | 249 mΩ @ 4.5 V | 1.2 A |
| | 299 mΩ @ 2.7 V | 1.27 |

N-Channel



MARKING DIAGRAM & PIN ASSIGNMENT





TS = Device Code

M = Date Code

Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping† |
|--------------|--------------------|--------------------|
| NTJS4405NT1G | SC-88 (Pb-Free) | 3000 / Tape & Reel |
| NVJS4405NT1G | SC-88 (Pb-Free) | 3000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25$ °C unless otherwise noted)

| Characteristic | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|---|--|------------------------|------|------|----------|-------|
| OFF CHARACTERISTICS | | | | | • | | • |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 25 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 30 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | T _J = 25°C | | | 1.0 | μΑ |
| | | $V_{DS} = 20 \text{ V}$ | T _J = 125°C | | | 10 | 1 |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 V, V_{G}$ | _{iS} = 8.0 V | | | 100 | nA |
| ON CHARACTERISTICS (Note 2) | | | | | | | - |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_{D}$ | = 250 μΑ | 0.65 | | 1.5 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -2.0 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, I_D = 0.6 \text{ A}$ | | | 249 | 350 | mΩ |
| | V _{GS} = 2.7 V, I _D | | _D = 0.2 A | | 299 | 400 | |
| | • | V _{GS} = 4.5 V, I _D = 1.2 A | | | 260 | | |
| Forward Transconductance | 9FS | V _{DS} = 5.0 V, I _D = 0.5 A | | | 0.5 | | S |
| CHARGES AND CAPACITANCES | - | | | | · | <u>-</u> | - |
| Input Capacitance | C _{ISS} | V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 10 V | | | 49 | 60 | pF |
| Output Capacitance | C _{OSS} | | | | 22.4 | 30 | |
| Reverse Transfer Capacitance | C _{RSS} | 100 | | | 8.0 | 12 | |
| Total Gate Charge | Q _{G(TOT)} | | | | 0.75 | 1.5 | nC |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 4.5 V, V _[| _{os} = 5.0 V, | | 0.10 | | 1 |
| Gate-to-Source Charge | Q_{GS} | I _D = 0.95 A | | | 0.30 | 0.50 | |
| Gate-to-Drain Charge | Q_{GD} | | | | 0.20 | 0.40 | 1 |
| SWITCHING CHARACTERISTICS (No | ote 3) | | | | | | - |
| Turn-On Delay Time | t _{d(ON)} | V_{GS} = 4.5 V, V_{DS} = 6.0 V, I_{D} = 0.5 A, R_{G} = 50 Ω | | | 6.0 | 12 | ns |
| Rise Time | t _r | | | | 4.7 | 8.0 | 1 |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 25 | 35 | 1 |
| Fall Time | t _f | | | | 41 | 60 | |
| DRAIN-SOURCE DIODE CHARACTE | RISTICS | | | | | | |
| Forward Diode Voltage | V_{SD} | V _{GS} = 0 V, I _S = 0.6 A | T _J = 25°C | | 0.82 | 1.20 | V |
| | | | | | | | |

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

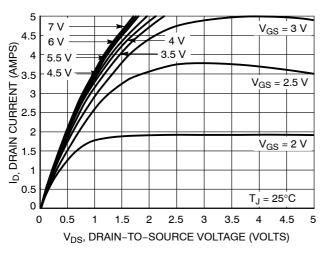


Figure 1. On-Region Characteristics

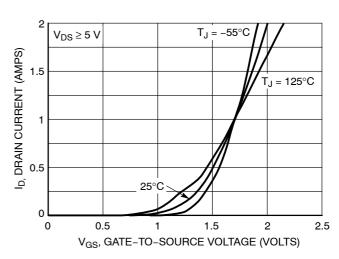


Figure 2. Transfer Characteristics

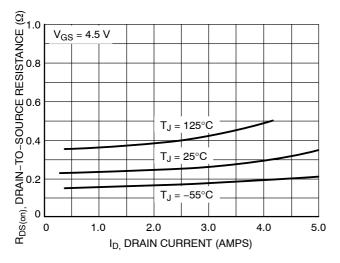


Figure 3. On-Resistance vs. Drain Current and Temperature

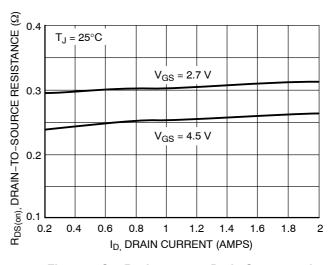


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

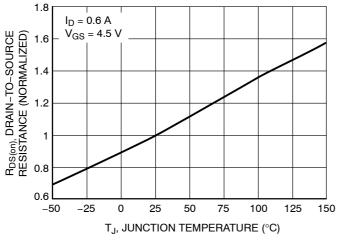


Figure 5. On–Resistance Variation with Temperature

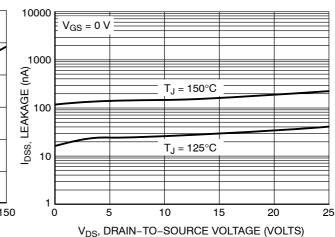


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

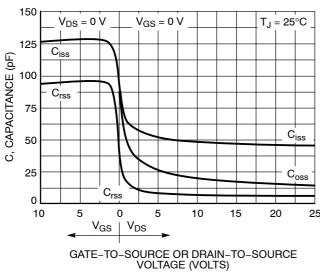


Figure 7. Capacitance Variation

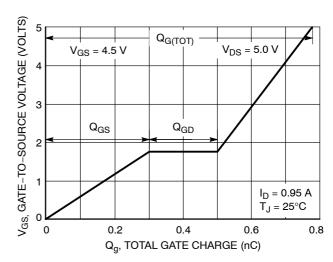


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

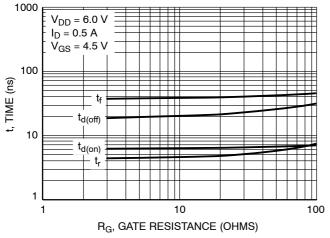


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

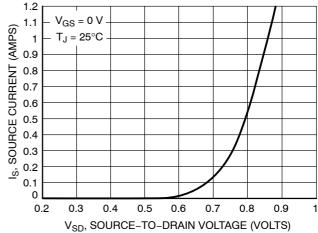


Figure 10. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

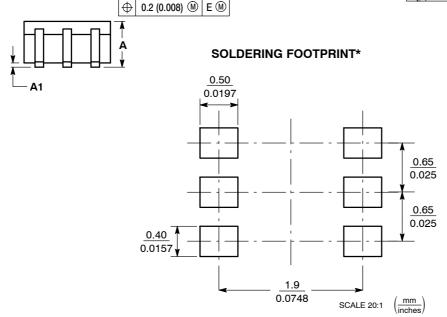
SC-88/SC70-6/SOT-363 CASE 419B-02 **ISSUE W**

 H_{E} -Eb 6 PI

NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- 419B-01 OBSOLETE, NEW STANDARD 419B-02.

| | MILLIMETERS | | | INCHES | | | |
|-----|-------------|----------|------|-----------|-----------|-------|--|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX | |
| Α | 0.80 | 0.95 | 1.10 | 0.031 | 0.037 | 0.043 | |
| A1 | 0.00 | 0.05 | 0.10 | 0.000 | 0.002 | 0.004 | |
| А3 | | 0.20 REF | | | 0.008 REF | | |
| b | 0.10 | 0.21 | 0.30 | 0.004 | 0.008 | 0.012 | |
| С | 0.10 | 0.14 | 0.25 | 0.004 | 0.005 | 0.010 | |
| D | 1.80 | 2.00 | 2.20 | 0.070 | 0.078 | 0.086 | |
| E | 1.15 | 1.25 | 1.35 | 0.045 | 0.049 | 0.053 | |
| е | 0.65 BSC | | | 0.026 BSC | | | |
| L | 0.10 | 0.20 | 0.30 | 0.004 | 0.008 | 0.012 | |
| HE | 2.00 | 2.10 | 2.20 | 0.078 | 0.082 | 0.086 | |



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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